

IIW International group for extending and Exchanging Welding knowledge

Publish Technical documents (Guidelines, Handbook,...)

Create ISO Standards

15 Commissions, One dedicated to Quality Control and NDT



<u>UT WG :</u> Eric Sjerve (Canada):

Phased array Handbook;

Phased array calibration block,

Guided waves (LRUT) guidelines

<u>XRay WG:</u> Uwe Ewert (Germany) Recent developments in standardisation of digital radiology for weld inspection

Electromagnetic techniques WG: Gerd Dobmann (Germany) Stress measurement



<u>New group : NDE reliability including simulation activities</u>

1.Objectives for simulation:

- Guidelines for simulation use in NDT (Continuation of the ENIQ document)

- How to validate models ? (Guidelines)
- Internationnal data basis and benchmarking



<u>New group : NDE reliability including simulation activities,</u>

2.Objectives for reliability:

- - Guidelines for POD assisted by Simulation : approach, extension of the existing approach in different area (importance of aeronautics, MAPOD)

- Have a frame to continue some new aspects in progress (Multi parameter, mixing empirical / simulated data,...)



Structure of the group:

- Experts from different countries, companies, institutes
- Most of the work is done through email for document

- Maximum 2 meetings/year, in conjunction with other events (ECNDT, QNDE, IIW annual seminar, ASNT,....)

Linked Projects or Group:

- French SISTAE
- European PICASSO
- ENIQ
- MAPOD group

The SISTAE project: Simulation and Statistics for Non Destructive Evaluation











Evaluation of POD Curves Based on Simulation Results

Background

• **Inspection reliability:** one of the key issues in ensuring safety of critical structural components

 Increasing use of probabilistic approaches based on statistical criteria such as POD curves and PFAs

• Are currently obtained thru **expensive and time consuming** experimental campaigns

Objective

• To replace some of the experimental data with **simulation results** such as those obtained with the software CIVA

Evaluation of POD Curves Based on Simulation Results

Factors affecting the probe signal response due to a flaw:

- NDI system (transducer, scan plan, electronic device)
- Part (geometry, material properties, surface roughness)
- Flaw (size, shape, orientation, position)

These factors are either deterministic or random in the simulation

Examples of random factors:

- Detail of metallurgical microstructure: structural noise, beam distortions
- Flaw morphology: for a fixed size, various parameters such as shape, orientation, position, elastic properties, and conductivity can vary in a random manner
 Lift-off variations and/or probe orientation during a manual inspection using an eddy current pencil probe

Modeling POD in CIVA: a general approach

- 1. Definition of the inspection setup using the CIVA graphical user interface
- 2. Description of uncertainties on a set of input parameters
- 3. Propagation of uncertainty and computation of noise using CIVA models
- 4. Evaluation of probabilistic criteria such as the POD, PFA, ROC...



A global methodology for the quantification of uncertainties by a CIVA model-based approach

Estimation of the POD curve using a functional form

 POD curves relate the detectability of a flaw to its size (or to another geometrical characteristic)

- Usual approach consist in:
 - assuming a functional form for the POD curve
 - > estimating the parameters of the function from the inspection results
 - estimating the associated confidence bound
- $Berens \begin{cases} \bullet \text{ Hit/miss data format:} \\ Log-odds function \\ \bullet \text{ Signal response data format:} \\ POD(a) = \left\{ 1 + \exp\left(-\frac{\pi}{\sqrt{3}}\left(\frac{\ln a}{\langle \sigma \rangle}\right)\right) \right\}^{-1} \\ POD(a) = \Phi\left[\left(\ln a \langle \mu \rangle / \langle \sigma \rangle\right)\right] \end{cases}$

Cheng Cheng Stribution a finite size data sample confidence bound

Application case: UT inspection of a tube section containing back wall breaking notches



Definition of uncertain parameters



Modeling uncertainty sources using statistical distributions



Modeling complex noise sources using specific algorithms The ultrasonic grain noise generator: Principle

• Synthetic microstructure: The polycrystalline structure is modeled as a set of randomly positioned scatterers. The scatterer density ρ is fixed by the user.

• A reflectivity is associated to each scatterer according to a zero mean Gaussian distribution. The standard-deviation σ characterizing the strength of scatterers is fixed thru the GUI.

• For each scanning position, the backscattered signal results from the super-imposition of signals coming from ideal back-scatterers in the medium.





Space and time coherence properties are well reproduced

Modeling complex noise sources using specific algorithms

The ultrasonic grain noise generator: statistical properties and Probability of False Alarm (PFA)



Bins of envelope amplitudes

Bins of C-scan pixel values

Good prediction of the statistical properties of C-scan pixel values Important to predict the PFA and an adequate detection threshold

Application case: Inspection of tube section containing back wall breaking notches

Definition of the statistical distributions defining the uncertain parameters

Notch tilt Notch skew Normal distribution, $\sigma = 1^{\circ}$ Probe orientation Notch length Normal distribution, $\sigma = 3$ mm

Selection of two different noise levels



 $\sigma = 125 \ \rho = 0.1 \ mm - 3 \\ SNR = 14 \ dB$



0.14

0.12 0.1

造 _{0.08}]

0.06

0.04

σ

0 Angle [¶



Application case: Inspection of tube section containing back wall breaking notches

â vs. a analysis (signal response data format)





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PICASSO

Structure through Simulation Supported PO

imProved reliabIlity inspection of Aeronautic structure through Simulation Supported POD



WHY PICASSO ?

• In the context of aging engines and increase of air traffic in next 20 years, it is crucial to have a reliable predictive maintenance to



Minimize unscheduled maintenance operations on engines which are cost and time consuming



Increase accuracy of damage tolerance analysis and consequently the level of safety

Main impacts of the project :



Improve the answer to FAA/EASA damage tolerance requirement with higher knowledge and accuracy on NDT inspection PODs



Savings in costs concerning aircraft maintenance and engine development (avoidance of the manufacturing of expensive samples with defects)

Objectives



« simulation supported POD curves based on NDT simulation in addition to existing experimental data base »





Objectives (2/2)



	Experimental POD	
Sample manufacturing	 Difficult to manufacture real defects Limited number of samples Limited number of defects 	
NDT inspection campaign	 Several operators needed Respect of the NDT procedure (sometimes operators change parameters for a better detection) 	
POD data exploitation	- Data collection	
New POD configuration	- Need to do a new POD campaign	





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ENIQ : European Network for Inspection Qualification

Qualification in the nuclear area :

For procedure's QualificationExperimental : open experimental trial + Technical justification including Modelling.

Up to now, very deterministic approach;

Evolution to technical justification including Simulation Assisted POD approach...